Ordering number : ENA0324



SANYO Semiconductors DATA SHEET

N-Channel Silicon MOSFET

2SK4065—General-Purpose Switching Device **Applications**

Features

- · Ultralow ON-resistance.
- · Load switching applications.
- · Avalanche resistance guarantee.

Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	VDSS		75	V
Gate-to-Source Voltage	VGSS	- THE WILLS	±20	V
Drain Current (DC)	ID	LAD TO A	100	Α
Drain Current (Pulse)	IDP	PW≤10μs, duty cycle≤1%	400	А
Allowable Power Dissipation	PD		1.65	W
		Tc=25°C	90	W
Channel Temperature	Tch		150	°C
Storage Temperature	Tstg		-55 to +150	°C
Avalanche Energy (Single Pulse) *1	EAS		735	mJ
Avalanche Current *2	I _{AV}		70	Α

Note: *1 V_{DD}=30V, L=200μH, I_AV=70A

Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			1.1-24
			min	typ	max	Unit
Drain-to-Source Breakdown Voltage	V(BR)DSS	I _D =1mA, V _{GS} =0V	75			V
Zero-Gate Voltage Drain Current	IDSS	V _{DS} =75V, V _{GS} =0V			1	μΑ
Gate-to-Source Leakage Current	IGSS	V _{GS} =±16V, V _{DS} =0V			±10	μΑ
Cutoff Voltage	VGS(off)	V _{DS} =10V, I _D =1mA	1.2		2.6	V
Forward Transfer Admittance	yfs	V _{DS} =10V, I _D =50A	47	78		S
Static Drain-to-Source On-State Resistance	R _{DS} (on)1	I _D =50A, V _{GS} =10V		4.6	6.0	mΩ
	R _{DS} (on)2	I _D =50A, V _{GS} =4V		5.7	8.0	mΩ

Marking: K4065 Continued on next page.

- Any and all SANYO Semiconductor products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your SANYO Semiconductor representative nearest you before usingany SANYO Semiconductor products described or contained herein in such
- SANYO Semiconductor assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all SANYO Semiconductor products described or contained herein.

^{*2} L≤200µH, Single pulse

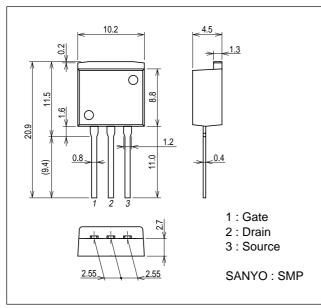
2SK4065

Continued from preceding page.

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Uill
Input Capacitance	Ciss	V _{DS} =20V, f=1MHz		12200		pF
Output Capacitance	Coss	V _{DS} =20V, f=1MHz		950		pF
Reverse Transfer Capacitance	Crss	V _{DS} =20V, f=1MHz		730		pF
Turn-ON Delay Time	t _d (on)	See specified Test Circuit.		80		ns
Rise Time	t _r	See specified Test Circuit.		460		ns
Turn-OFF Delay Time	t _d (off)	See specified Test Circuit.		930		ns
Fall Time	tf	See specified Test Circuit.		640		ns
Total Gate Charge	Qg	V _{DS} =35V, V _{GS} =10V, I _D =100A		220		nC
Gate-to-Source Charge	Qgs	V _{DS} =35V, V _{GS} =10V, I _D =100A		40		nC
Gate-to-Drain "Miller" Charge	Qgd	V _{DS} =35V, V _{GS} =10V, I _D =100A		50		nC
Diode Forward Voltage	VSD	I _S =100A, V _G S=0V		0.9	1.2	V

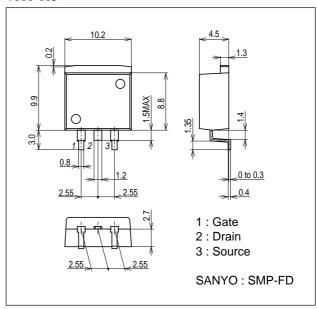
Package Dimensions

unit : mm 7513-002

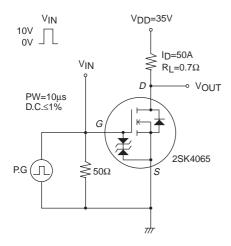


Package Dimensions

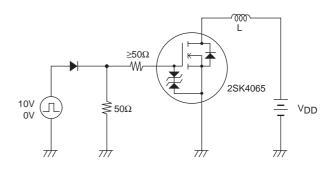
unit : mm 7001-003

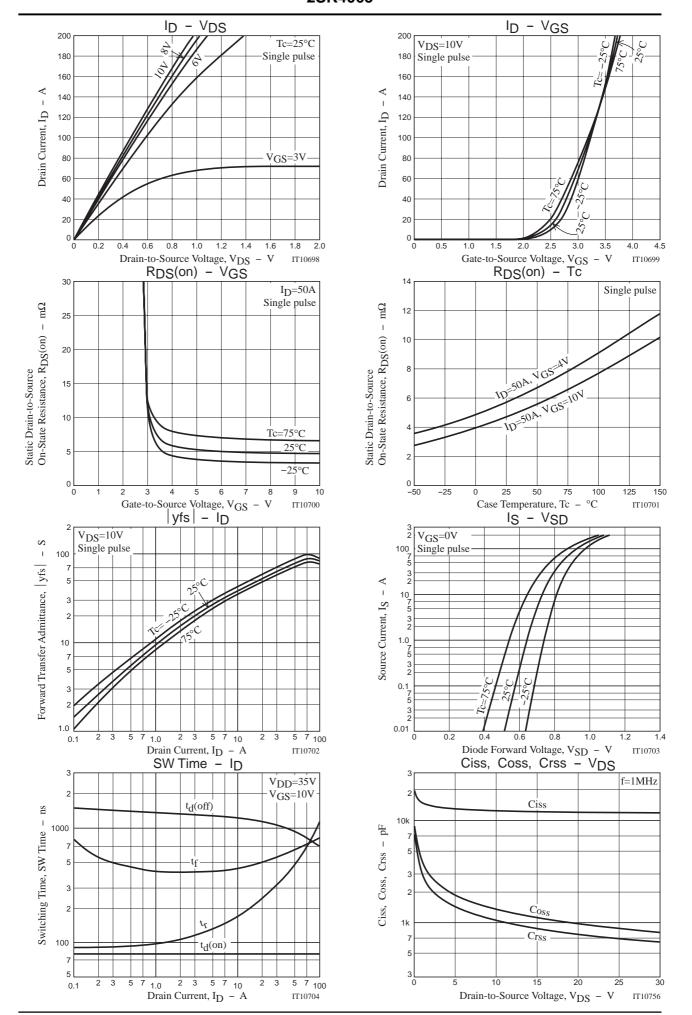


Switching Time Test Circuit

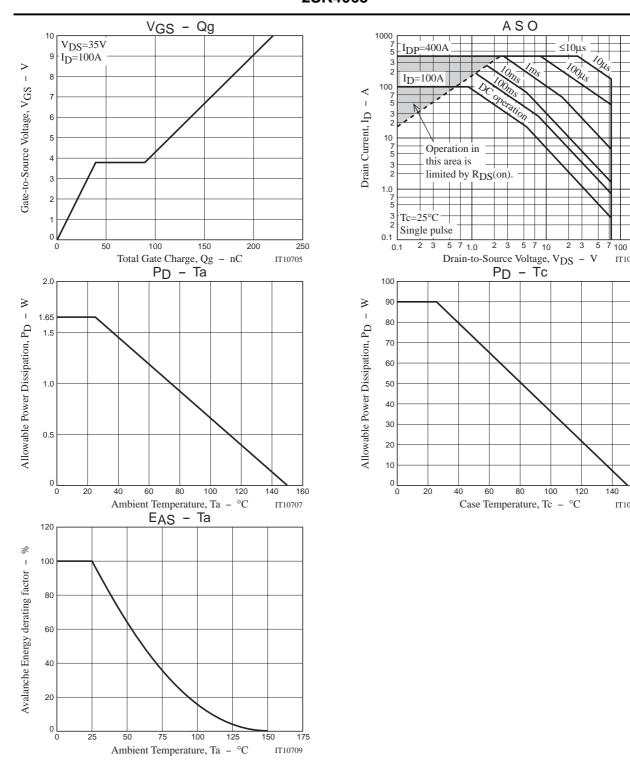


Avalanche Resistance Test Circuit





2SK4065



IT10708

2SK4065

Note on usage: Since the 2SK4065 is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

- Specifications of any and all SANYO Semiconductor products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.
- SANYO Semiconductor Co., Ltd. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with some probability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.
- In the event that any or all SANYO Semiconductor products (including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from the authorities concerned in accordance with the above law.
- No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of SANYO Semiconductor Co., Ltd.
- Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the SANYO Semiconductor product that you intend to use.
- Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production. SANYO Semiconductor believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.

This catalog provides information as of April, 2006. Specifications and information herein are subject to change without notice.